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 PATENT & TRADEMARK OFFICE

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 14157-011001	Application No. 10/627,353
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Fumio Saitoh et al.	
		Filing Date July 25, 2003	Group Art Unit

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
<i>JS</i>	AA	4,668,448	05/26/87	Weber et al.	264	22	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
<i>JS</i>	AL	0 990 673 A2	04/05/00	EP	G08G	73/22		
	AM	0 172 012	02/19/86	EP	C09K	19/02		
	AN	0 171 017 A2	02/12/86	EP	B29C	67/24		
	AO	7-13168	01/17/95	JP	G02F	1/1337		
	AP	WO 95/19386	07/20/95	WIPO	C08J	5/18		
	AQ	WO 93/23460	11/25/93	WIPO	C08J	5/18		
<i>JS</i>	AR	WO 93/06191	04/01/93	WIPO	C09K	19/00		

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AS	
	AT	
	AU	
	AV	

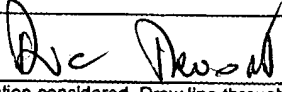
Examiner Signature 	Date Considered 6/20/04
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

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							Yes	No
AK	AK	2001-011311	01/16/01	JP	C08L	79/06		
AL	AL	2000-273214	10/03/00	JP	C08J	5/18		
AM	AM	11-171993	06/29/99	JP	C08G	73/22		
AN	AN	6-503521	04/21/94	JP	B29C	55/02		
AO	AO	04-202257	07/23/92	JP	C08L	81/00		
AP	AP	63-074612	04/05/88	JP	B29C	41/12		

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